

Search Notes

Application/Control No.

09/632,774

Examiner

Tri V. Nguyen

Applicant(s)/Patent under
Reexamination

HAITSUKA ET AL.

Art Unit

1751

SEARCHED

Class	Subclass	Date	Examiner
705	14	5/5/2007	NVT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (see attached)	5/5/2007	NVT